

Search Notes

Application/Control No.

10/774,220

Examiner

Sean P. Shechtman

Applicant(s)/Patent under
Reexamination

VANDERWIEL, THOMAS J.

Art Unit

2125

SEARCHED

Class	Subclass	Date	Examiner
700	28,29,83,8 6,97,98,10 4,117,180		
700	182		
718	101		
703	1	4/28/2005	SPS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search Attached	4/28/2005	SPS